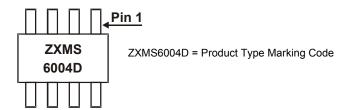
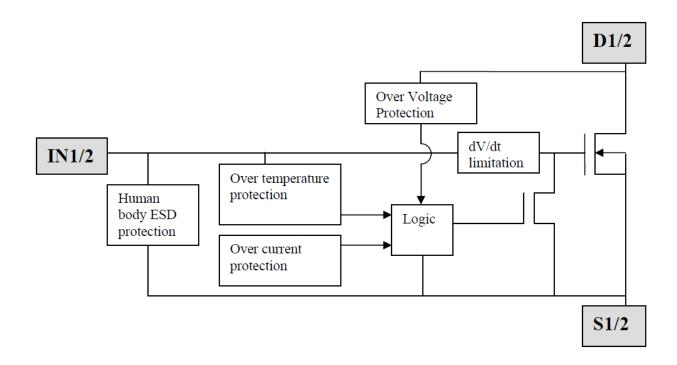


## **Marking Information**



# **Functional Block Diagram**





#### Absolute Maximum Ratings (@T<sub>amb</sub> = +25°C, unless otherwise stated.)

Characteristic	Symbol	Value	Units
Continuous Drain-Source Voltage	$V_{DS}$	60	V
Drain-Source Voltage For Short Circuit Protection	V <sub>DS(SC)</sub>	36	V
Continuous Input Voltage	$V_{IN}$	-0.5 +6	V
Continuous Input Current @ $-0.2V \le V_{IN} \le 6V$ Continuous Input Current @ $V_{IN} < -0.2V$ or $V_{IN} > 6V$	lin	No limit	mA
Pulsed Drain Current @V <sub>IN</sub> = 3.3V (Note 8)	$I_{DM}$	2	A
Pulsed Drain Current @V <sub>IN</sub> = 5V (Note 8)	I <sub>DM</sub>	2.5	Α
Continuous Source Current (Body Diode) (Note 6)	Is	1	A
Pulsed Source Current (Body Diode) (Note 8)	I <sub>SM</sub>	5	Α
Unclamped Single Pulse Inductive Energy, $T_J = +25^{\circ}C$ , $I_D = 0.5A$ , $V_{DD} = 24V$	Eas	210	mJ
Electrostatic Discharge (Human Body Model)	V <sub>ESD</sub>	4000	V
Charged Device Model	V <sub>CDM</sub>	1000	V

#### **Thermal Resistance**

Characteristic	Symbol	Value	Units
Power Dissipation at T <sub>amb</sub> = +25°C (Notes 6 & 9) Linear Derating Factor	P <sub>D</sub>	1.16 9.28	W mW/°C
Power Dissipation at T <sub>amb</sub> = +25°C (Notes 6 & 10) Linear Derating Factor	P <sub>D</sub>	1.67 13.3	W mW/°C
Power Dissipation at T <sub>amb</sub> = +25°C (Notes 7 & 9) Linear Derating Factor	P <sub>D</sub>	2.13 17	W mW/°C
Thermal Resistance, Junction to Ambient (Notes 6 & 9)	$R_{\theta JA}$	108	°C/W
Thermal Resistance, Junction to Ambient (Notes 6 & 10)	R <sub>θJA</sub>	75	°C/W
Thermal Resistance, Junction to Case (Notes 7 & 9)	R <sub>θJC</sub>	58.7	°C/W
Thermal Resistance, Junction to Case (Note 11)	R <sub>θJC</sub>	26.5	°C/W
Operating Temperature Range	TJ	-40 to +150	°C
Storage Temperature Range	T <sub>STG</sub>	-55 to +150	°C

Notes:

- 6. For a dual device surface mounted on a 25mm x 25mm FR4 PCB single sided 1oz weight copper split down the middle on 1.6mm FR4 board, in still air conditions
- 7. For a dual device surface mounted on FR4 PCB measured at t ≤ 10sec
- 8. Repetitive rating 25mm x 25mm FR4 PCB, D = 0.02 pulse width = 300µs pulse width limited by junction temperature. Refer to transient Thermal Impedance Graph
- 9. For a dual device with one active die
- 10. For dual device with 2 active die running at equal power
- 11. Thermal resistance from junction to solder-point (at the end of the drain lead)

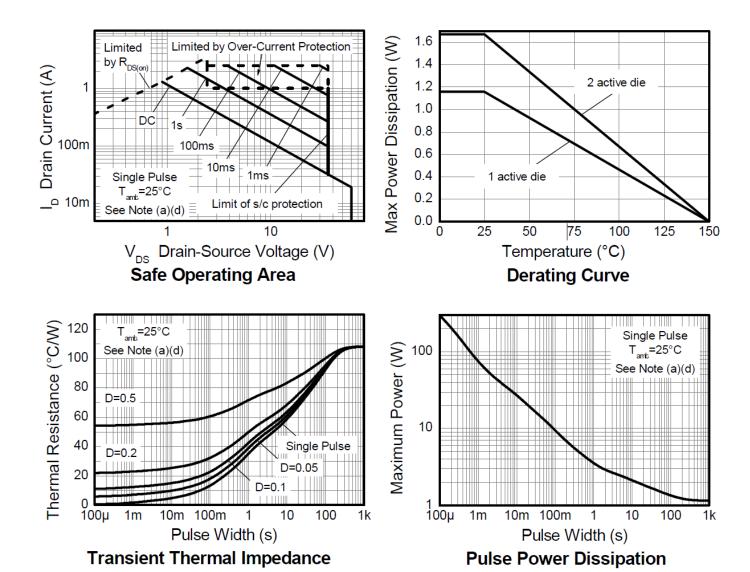
#### **Recommended Operating Conditions**

The ZXMS6004DT8Q is optimized for use with  $\mu C$  operating from 3.3V and 5V supplies.

Characteristic	Symbol	Min	Max	Unit
Input Voltage Range	$V_{IN}$	0	5.5	V
Ambient Temperature Range	T <sub>A</sub>	-40	125	°C
High Level Input Voltage for MOSFET to be on	V <sub>IH</sub>	3	5.5	V
Low Level Input Voltage for MOSFET to be off	$V_{IL}$	0	0.7	V
Peripheral Supply Voltage (Voltage to Which Load is Referred)	V <sub>P</sub>	0	36	V



#### **Thermal Characteristics**





# Electrical Characteristics (@T<sub>amb</sub> = +25°C, unless otherwise stated.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
Static Characteristics						
Drain-Source Clamp Voltage	$V_{DS(AZ)}$	60	65	70	V	$I_D = 10mA$
Off State Drain Current	I <sub>DSS</sub>		_	0.5	μΑ	$V_{DS} = 12V, V_{IN} = 0V$
On State Drain Current			_	1		$V_{DS} = 36V, V_{IN} = 0V$
Input Threshold Voltage	V <sub>IN(th)</sub>	0.7	1	1.5	V	$V_{DS} = V_{GS}$ , $I_D = 1mA$
Input Current	I <sub>IN</sub>		60	100	μA	$V_{IN} = +3V$
Input Current			120	200		$V_{IN} = +5V$
Input Current while Over Temperature Active	_		_	220	μΑ	$V_{IN} = +5V$
Static Drain-Source On-State Resistance	R <sub>DS(on)</sub>		400	600	mΩ	$V_{IN} = +3V$ , $I_{D} = 1A$
Static Dialii-Source Oil-State Resistance			350	500		$V_{IN} = +5V, I_D = 1A$
Continuous Drain Current (Notes 6 & 10)	- I <sub>D</sub>	0.9	_	_		$V_{IN} = 3V; T_A = +25^{\circ}C$
Continuous Diain Current (Notes 6 & 10)		1	_	_	А	$V_{IN} = 5V; T_A = +25^{\circ}C$
Continuous Drain Current (Notes 6 & 9)		1.1	_	_		$V_{IN} = 3V; T_A = +25^{\circ}C$
Continuous Brain Current (Notes 6 & 9)		1.2	_	_		$V_{IN} = 5V; T_A = +25^{\circ}C$
Current Limit (Note 12)	I <sub>D(LIM)</sub>	0.7	1.7	_	Α	$V_{IN} = +3V$
Current Limit (Note 12)		1	2.2	_		$V_{IN} = +5V$
Dynamic Characteristics						
Turn On Delay Time	t <sub>d(on)</sub>		5	_	μs	
Rise Time	t <sub>r</sub>		10	_	μs	$V_{DD} = 12V, I_D = 0.5A,$
Turn Off Delay Time	t <sub>d(off)</sub>		45	_	μs	V <sub>GS</sub> = 5V
Fall Time	f <sub>f</sub>	-	15	_	μs	
Over-Temperature Protection						
Thermal Overload Trip Temperature (Note 13)	$T_{JT}$	150	175	_	°C	
Thermal Hysteresis (Note 13)	_	_	10	_	°C	_

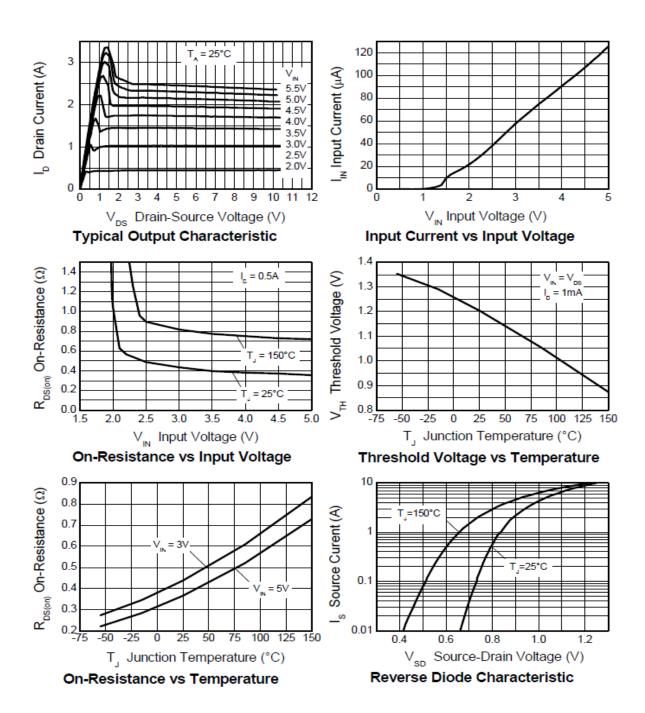
Notes: 12. The drain current is restricted only when the device is in saturation (see graph "Typical Output Characteristic"). This allows the device to be used in the fully on state without interference from the current limit. The device is fully protected at all drain currents, as the low power dissipation generated outside saturation makes current limit unnecessary.

asturation makes current limit unnecessary.

13. Over-temperature protection is designed to prevent device destruction under fault conditions. Fault conditions are considered as "outside" normal operating range, so this part is not designed to withstand over-temperature for extended periods.

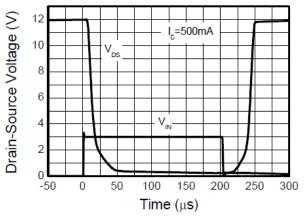


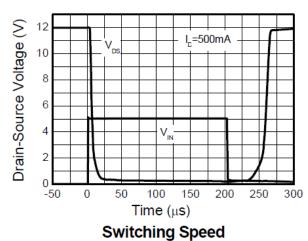
#### **Typical Characteristics**



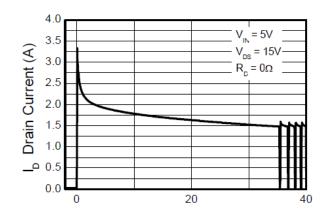


## Typical Characteristics - (cont.)





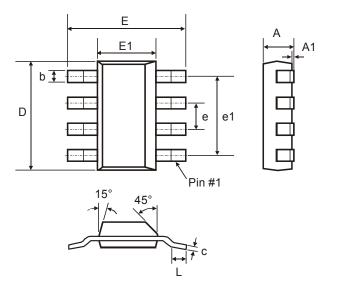
## **Switching Speed**





## **Package Outline Dimensions**

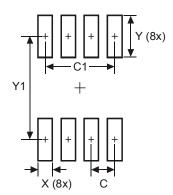
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SM-8					
Dim	Min	Max	Тур		
Α	-	1.7	_		
A1	0.02	0.1	-		
b	_	0.7	-		
С	0.24	0.32	-		
D	6.3	6.7	-		
е	_	_	1.53		
e1	-	-	4.59		
Е	6.7	7.3	_		
E1	3.3	3.7	_		
L	0.9	_	_		
All	All Dimensions in mm				

## **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	1.52
C1	4.6
Х	0.95
Y	2.80
Y1	6 80



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